TRS3122E 1.8 V Low Power Dual RS-232 Transceiver

1 Features

- Extended V_{CC} operating nodes: 1.8 V, 3.3 V, or 5.0 V
  - Unique Tripler Charge Pump Architecture Enables Low V_{CC} of 1.8V While Maintaining Compatibility with 3.3 V and 5 V Supplies
- Integrated Level-Shifting Functionality Eliminates the Need for External Power or Additional Level Shifter While Interfacing with Low-Voltage MCUs
- Enhanced ESD Protection on RIN Inputs and DOUT Outputs
  - ±15 kV IEC 61000-4-2 Air-Gap Discharge
  - ±8 kV IEC 61000-4-2 Contact Discharge
  - ±15 kV Human-Body Model
- Specified 1000-kbps Data Rate
- Auto Powerdown Plus Feature
- Low 0.5uA Shutdown Supply Current
- Meets or Exceeds Compatibility Requirements of RS-232 Interface
- For 2.5 V Single Supply Applications, Consider TRS3318E as an Optimized Solution

2 Applications

- Remote Radio Unit (RRU)
- Base Band Unit (BBU)
- Electronic Point of Sale (EPOS)
- Diagnostics & Data Transmission
- Battery-Powered Equipment

3 Description

The TRS3122E is a two-driver and two-receiver RS-232 interface device, with split supply pins for mixed-voltage operation. All RS-232 inputs and outputs are protected to ±15 kV using the IEC 61000-4-2 Air-Gap Discharge method, ±8 kV using the IEC 61000-4-2 Contact Discharge method, and ±15 kV using the Human-Body Model.

The charge pump requires five small 0.1-µF capacitors for operation from as low as a 1.8-V supply. The TRS3122E is capable of running at data rates up to 1000 kbps, while maintaining RS-232-compatible output levels.

The TRS3122E has a unique V_L pin that allows operation in mixed-logic voltage systems. Both driver in (DIN) and receiver out (ROUT) logic levels are pin programmable through the V_L pin. This eliminates the need for additional voltage level shifter while interfacing with low-voltage microcontrollers or UARTs.

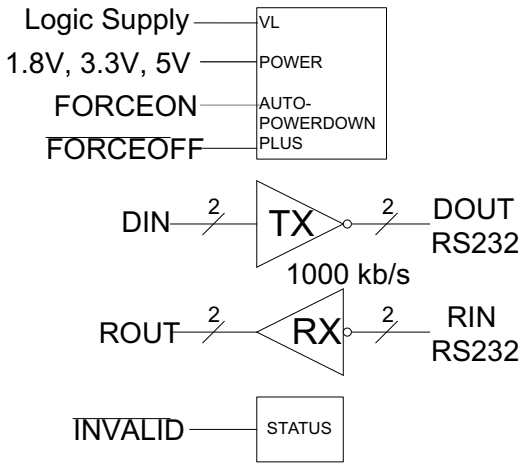
Auto Powerdown Plus automatically places the device in a low power mode when the device has not received or transmitted data for more than 30 seconds. This feature makes this device a very attractive option for battery powered or other power-sensitive applications.

Device Information[1]

PART NUMBER	PACKAGE (PINS)	BODY SIZE (NOM)
TRS3122ERGER	RGE (24)	4.00 mm × 4.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Feature Diagram



Copyright © 2016, Texas Instruments Incorporated

Table of Contents

1 Features ... 1
2 Applications ... 1
3 Description ... 1
4 Revision History ... 2
5 Pin Configuration and Functions ... 3
6 Specifications ... 4
6.1 Absolute Maximum Ratings ... 4
6.2 ESD Ratings ... 4
6.3 Recommended Operating Conditions ... 5
6.4 Thermal Characteristics ... 5
6.5 Power and Status Electrical Characteristics ... 5
6.6 Driver Electrical Characteristics ... 6
6.7 Receiver Electrical Characteristics ... 6
6.8 Driver Switching Characteristics ... 6
6.9 Receiver Switching Characteristics ... 7
6.10 Power and Status Switching Characteristics ... 7
6.11 Typical Characteristics ... 8
7 Parameter Measurement Information ... 9
8 Detailed Description ... 12
8.1 Overview ... 12
8.2 Functional Block Diagram ... 12
8.3 Feature Description ... 13
8.4 Device Functional Modes ... 15
9 Application and Implementation ... 16
9.1 Application Information ... 16
9.2 Typical 1.8-V Application ... 16
10 Power Supply Recommendations ... 18
11 Layout ... 19
11.1 Layout Guidelines ... 19
11.2 Layout Example ... 19
12 Device and Documentation Support ... 20
12.1 Device Support ... 20
12.2 Community Resources ... 20
12.3 Trademarks ... 20
12.4 Electrostatic Discharge Caution ... 20
12.5 Glossary ... 20
13 Mechanical, Packaging, and Orderable Information ... 20

4 Revision History

Changes from Revision B (May 2016) to Revision C — **Page**

- Reordered bullets in *Features* section by priority ... 1
- Deleted Data Cables from *Applications* section of front page to make room for front page image ... 1
- Changed Corrected swapped ESD levels in description text ... 1

Changes from Revision A (May 2016) to Revision B — **Page**

- Updated ESD ratings values to reflect current device specifications ... 4
- Added all Typical Characteristic graphs and schematics to the *Typical Characteristics* section ... 8
- Added Application Curve image to *Application Curves* section ... 18

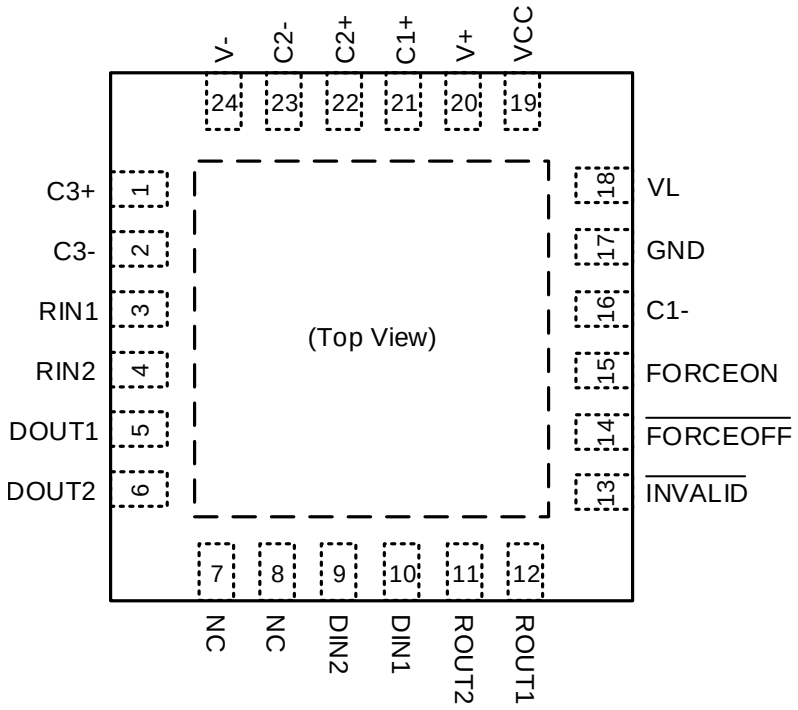
Changes from Original (June 2014) to Revision A — **Page**

- Added Pin Functions table. ... 3

Copyright © 2016, Texas Instruments Incorporated

5 Pin Configuration and Functions

VQFN P Package
24-Pin RGE
Top View



Pin Functions

Pin		I/O	DESCRIPTION
NAME	NO.		
C1+, C2+	21, 22	-	Positive terminals of voltage-doubler charge-pump capacitors (required)
C3+	1	-	Positive terminal of voltage-tripler charge-pump capacitor (Not needed for VCC 3V to 5.5V)
C1–, C2-	16, 23	-	Negative terminals of voltage-doubler charge-pump capacitors (required)
C3-	2	-	Negative terminal of voltage-tripler charge-pump capacitor (Not needed for VCC 3V to 5.5V)
V+	20	-	Positive charge pump storage capacitor (required)
V–	24	-	Negative charge pump storage capacitor (required)
GND	17	-	Ground
V_{CC}	19	-	1.8-V or 3-V to 5-V supply voltage
V_L	18	-	Logic-level supply. All CMOS inputs (DIN) and outputs (ROUT) are referenced to this supply.
$\overline{\text{FORCEOFF}}$	14	I	Auto Powerdown Control input (Refer to Truth Table)
FORCEON	15	I	Auto Powerdown Control input (Refer to Truth Table)
$\overline{\text{INVALID}}$	13	O	Invalid Output Pin
DIN1, DIN2	10,9	I	Driver inputs
DOUT1, DOUT2	5, 6	O	RS-232 driver outputs
RIN1, RIN2	3, 4	I	RS-232 receiver inputs
ROUT1, ROUT2	12, 11	O	Receiver outputs; swing between 0 and V_L
NC	7, 8	I	Factory pins, can be unconnected or connected to GND

Copyright © 2016, Texas Instruments Incorporated

6 Specifications

6.1 Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Charge pump power supply		–0.3	6	V
V_L	Logic power supply		–0.3	6	V
V+	Positive storage capacitor voltage		–0.3	7	V
V–	Negative storage capacitor voltage		0.3	–7	V
	V+ + |V–|(2)			13	V
V_I	Input voltage	$\overline{\text{FORCEOFF}}$, FORCEON	–0.3	6	V
		DIN	–0.3	V_L + 0.3	
		RIN (0Ω series resistance)		±20	
		RIN (≥250Ω series resistance)		±25	
V_O	Output voltage	DOUT		±13.2	V
		ROUT	–0.3	V_L + 0.3	
T_J	Junction temperature			150	°C
T_{stg}	Storage temperature range		–65	150	°C

(1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
(2) V+ and V– can have maximum magnitudes of 7 V, but their absolute difference cannot exceed 13 V.

6.2 ESD Ratings

				VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(1)	All pins except RS-232 bus	±2000	V
			RS-232 bus pins	±15000	
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins(2)	All pins	±500	
		IEC 61000-4-2 Air-Gap Discharge	RS-232 bus pins	±15000	
		IEC 61000-4-2 Contact Discharge		±8000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

Copyright © 2016, Texas Instruments Incorporated

6.3 Recommended Operating Conditions

				MIN	TYP	MAX	UNIT
V_{CC}	Charge pump power supply		Tripler Mode	1.65	1.8	2	V
			Doubler Mode	3	3.3	3.6	
				4.5	5	5.5	
V_L	Logic power supply			1.65		V_{CC}	V
RIN	RS-232 Receiver interface			-15		15	V
DOUT	RS-232 Transmitter interface			-12		12	V
V_{IL}	GPIO Input logic threshold low	DIN, $\overline{\text{FORCEOFF}}$, FORCEON	V_L = 5.0 V	0		1.7	V
			V_L = 3.3V	0		1.1	
			V_L = 1.8 V	0		0.6	
V_{IH}	GPIO Input logic threshold high	DIN, $\overline{\text{FORCEOFF}}$, FORCEON	V_L = 5.0V	3.3		V_L	V
			V_L = 3.3V	2.2		V_L	
			V_L = 1.8V	1.2		V_L	
V_{OZ}	ROUT disabled		$\overline{\text{FORCEOFF}}$ = 0V	0		V_L	V
	Operating temperature			–40		85	°C

6.4 Thermal Characteristics

THERMAL METRIC		TRS3122E	UNIT
		RGE	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	34.2	°C/W
$R_{\theta JCtop}$	Junction-to-case (top) thermal resistance	27.2	
$R_{\theta JB}$	Junction-to-board thermal resistance	11.4	
ψ_{JT}	Junction-to-top characterization parameter	0.4	
ψ_{JB}	Junction-to-board characterization parameter	11.4	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	3.6	

6.5 Power and Status Electrical Characteristics

V_{CC} = V_L = (1.65 V to 2.0 V) & (3.0V to 5.5V), T_A = -40°C to 85°C (unless otherwise noted). Typical data is T_A = 25°C, V_{CC} = V_L = 3.3V unless otherwise noted.

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
Icc (Static)		DIN1 = GND or V_L; DIN2 = GND or V_L, $\overline{\text{FORCEOFF}}$ = V_L FORCEON = V_L	No load	V_{CC}= 1.65V to 2.0V		1.0	1.9	mA
				V_{CC}= 3.0V to 3.6V		0.7	1.4	
				V_{CC}= 4.5V to 5.5V		0.8	1.9	
Icc (off)		$\overline{\text{FORCEOFF}}$ = GND				0.4	10	µA
V_{IT+}	RIN postive voltage threshold for $\overline{\text{INVALID}}$ output change	RIN1 = RIN2			0.3		2.4	V
V_{IT-}	RIN negative voltage threshold for $\overline{\text{INVALID}}$ output change				-2.4		-0.3	
V_{OH}	$\overline{\text{INVALID}}$ high-level output voltage	I_{OH} = -1 mA, FORCEON = GND, $\overline{\text{FORCEOFF}}$ = VL			V_L-0.4	V_L-0.08	V_L	V
V_{OL}	$\overline{\text{INVALID}}$ low-level output voltage	I_{OL} = 1.6 mA, FORCEON = GND, $\overline{\text{FORCEOFF}}$ = VL			0	0.06	0.4	V

Copyright © 2016, Texas Instruments Incorporated

6.6 Driver Electrical Characteristics

V_{CC} = V_L = (1.65 V to 2.0 V) & (3.0V to 5.5V), T_A = -40°C to 85°C (unless otherwise noted). Typical data is T_A = 25°C, V_{CC} = V_L = 3.3V unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OUT}	Output voltage swing	All driver outputs loaded with 3 kΩ to ground C3 = 100 nF, V_{CC}= 1.8 V	±4.25	±4.7		V
		All driver outputs loaded with 3 kΩ to ground C3 = 0 F, V_{CC}= 3.3 V or 5 V	±5	±5.4		
r_O	Output resistance	(V_{CC} = V+ = V– = 0); Driver output = ±2 V	300	10M		Ω
I_{OS}	Output short-circuit current	V_{DOUT} = 0			±60	mA
I_{OZ}	Output leakage current	V_{DOUT} = ±12 V, $\overline{\text{FORCEOFF}}$ = GND	0		±25	µA
	Driver input hysteresis			0.5	1	V
	Input leakage current	DIN = GND to V_L; $\overline{\text{FORCEOFF}}$ = GND to V_L; FORCEON = GND to V_L		0	±5	µA

6.7 Receiver Electrical Characteristics

V_{CC} = V_L = (1.65 V to 2.0 V) & (3.0V to 5.5V), T_A = -40°C to 85°C (unless otherwise noted). Typical data is T_A = 25°C, V_{CC} = V_L = 3.3V unless otherwise noted.

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
I_{off}	Output leakage current	ROUT, receivers disabled			±0.01	±10	µA
V_{OL}	Output voltage low	I_{OUT}= 2.0 mA			0.04	0.3	V
V_{OH}	Output voltage high	I_{OUT}= –2.0mA		V_L–0.3	V_L–0.04		V
$V_{IT–}$	Input threshold low	T_A=25°C	V_L= 5 V	0.8	1.5		V
			V_L= 3.3 V	0.7	1.1		
			V_L= 1.8 V	0.6	0.7		
V_{IT+}	Input threshold high	T_A =25°C	V_L= 5 V		2.0	2.4	V
			V_L = 3.3 V		1.5	2.4	
			V_L= 1.8 V		0.9	1.4	
V_{hys}	Input hysteresis	T_A=25°C	V_L= 5 V		0.45		V
			V_L = 3.3 V		0.35		
			V_L= 1.8 V		0.26		
	Input resistance	T_A=-40 to 85°C		3	5	7	kΩ

6.8 Driver Switching Characteristics

V_{CC} = V_L = (1.65 V to 2.0 V) & (3.0V to 5.5V), T_A = -40°C to 85°C (unless otherwise noted). Typical data is T_A = 25°C, V_{CC} = V_L = 3.3V unless otherwise noted.

PARAMETER				MIN	TYP	MAX	UNIT
	Maximum data rate	R_L = 3 kΩ, C_L = 500 pF (one driver)		1000			kbps
		R_L = 3 kΩ, C_L = 1000 pF (one driver)		500			
	Time-to-exit powerdown	$\|V_{DOUT}\|$ > 3.7 V			30	150	µs
$\|t_{PHL} – t_{PLH}\|$	Driver skew(1)	R_L = 3 kΩ		0	50	100	ns
	Transition-region slew rate	R_L = 3 kΩ to 7 kΩ, T_A = 25°C Measured from 3 V to –3 V or –3 V to 3 V	VCC = 1.8V, C_L = 200 pF		33		V/µs
			VCC = 1.8V, C_L = 1000 pF		25		
			VCC = 3.3 V, C_L = 200 pF		38		
			VCC = 3.3 V, C_L = 1000 pF		28		
			VCC = 5 V, C_L = 200 pF		41		
			VCC = 5 V, C_L = 1000 pF		30		

(1) Driver skew is measured at the driver zero crosspoint.

Copyright © 2016, Texas Instruments Incorporated

6.9 Receiver Switching Characteristics

V_{CC} = V_L = (1.65 V to 2.0 V) & (3.0V to 5.5V), T_A = -40°C to 85°C (unless otherwise noted). Typical data is T_A = 25°C, V_{CC} = V_L = 3.3V unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PHL}	Receiver propagation delay, high to low	Receiver input to receiver output C_L = 150 pF		0.15	0.4	µs
t_{PLH}	Receiver propagation delay, low to high			0.15	0.4	
$t_{PHL} - t_{PLH}$	Receiver skew			50	300	ns
t_{en}	Receiver output enable time	From $\overline{FORCEOFF}$ to ROUT= $V_L/2$ CL = 150 pF, RL = 3 kΩ		200	400	ns
t_{dis}	Receiver output disable time			200	400	ns

6.10 Power and Status Switching Characteristics

V_{CC} = V_L = (1.65 V to 2.0 V) & (3.0V to 5.5V), T_A = -40°C to 85°C (unless otherwise noted). Typical data is T_A = 25°C, V_{CC} = V_L = 3.3V unless otherwise noted.

PARAMETER		MIN	TYP	MAX	UNIT
t_{valid}	Propagation delay time, low- to high-level output		1		µs
$t_{invalid}$	Propagation delay time, high- to low-level output		30		µs
t_{dis}	Receiver or driver edge to auto-powerdown plus	15	30	60	s

Copyright © 2016, Texas Instruments Incorporated

6.11 Typical Characteristics

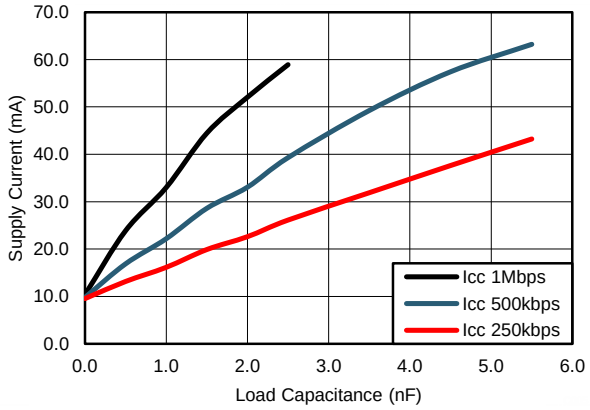


Figure 1. Supply Current vs. Load Capacitance
V_{CC} = 3.3 V, V_L = 1.8 V, R_{LOAD} = 3 kΩ, CH2 = 32 kbps

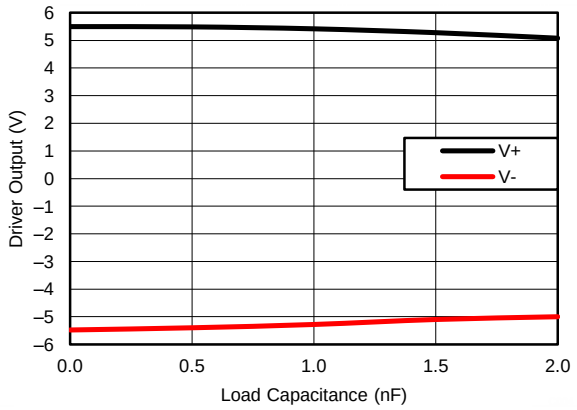


Figure 2. Driver Output vs. Load Capacitance, V_{CC} = 3.3V
V_L = 1.8V, R_{LOAD} = 3 kΩ, CH1 = 1 Mbps, CH2 = 32 kbps

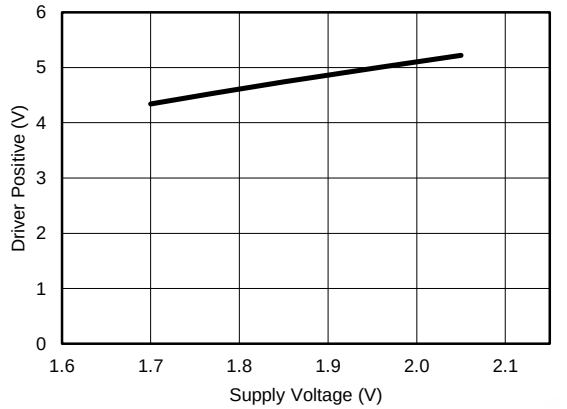


Figure 3. Driver Positive vs. Supply Voltage (Tripler Mode)
1 Mbps, R_{LOAD} = 3 kΩ, C_{LOAD} = 560 pF

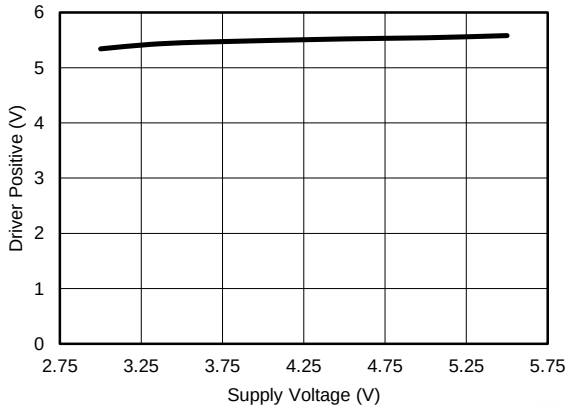


Figure 4. Driver Positive vs. Supply Voltage (Doubler Mode)
1 Mbps, R_{LOAD} = 3 kΩ, C_{LOAD} = 560 pF

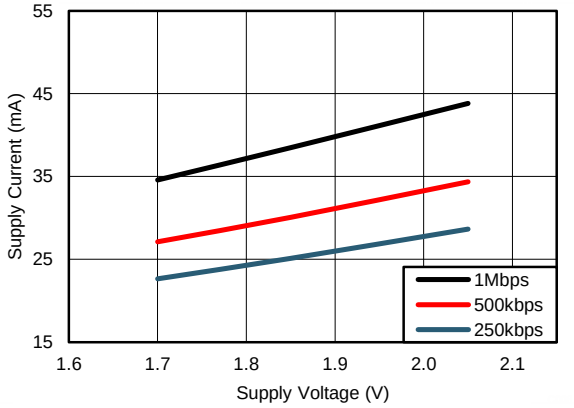


Figure 5. Supply Current vs. Supply Voltage (Tripler Mode)
V_L = 1.8 V, R_{LOAD} = 3 kΩ, C_{LOAD} = 1 nF, CH2 = 32 kbps

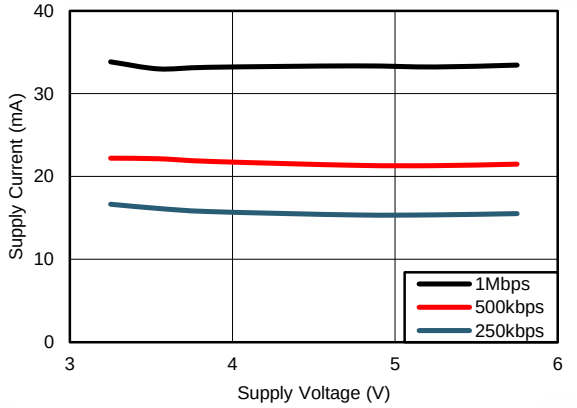
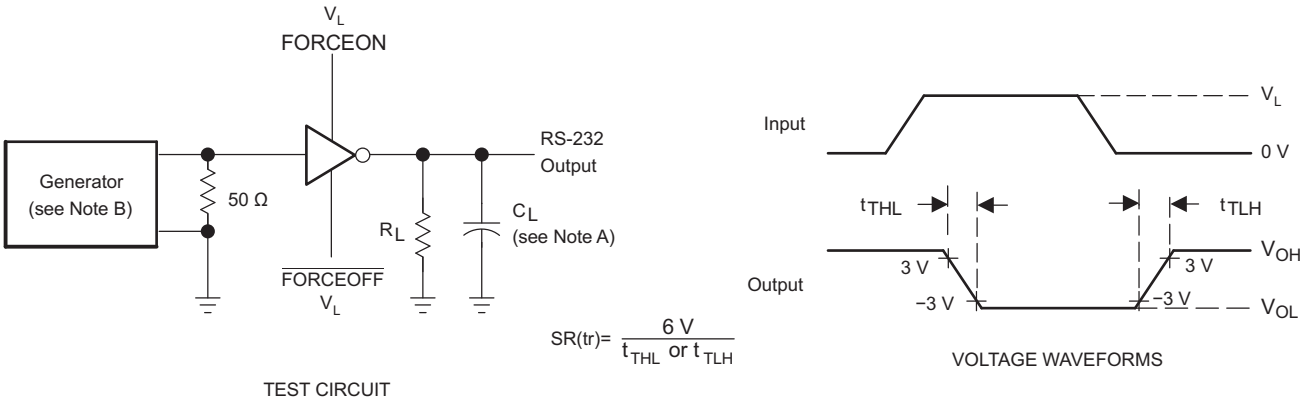


Figure 6. Supply Current vs. Supply Voltage (Doubler Mode)
V_L = 1.8 V, R_{LOAD} = 3 kΩ, C_{LOAD} = 1 nF, CH2 = 32 kbps

Copyright © 2016, Texas Instruments Incorporated

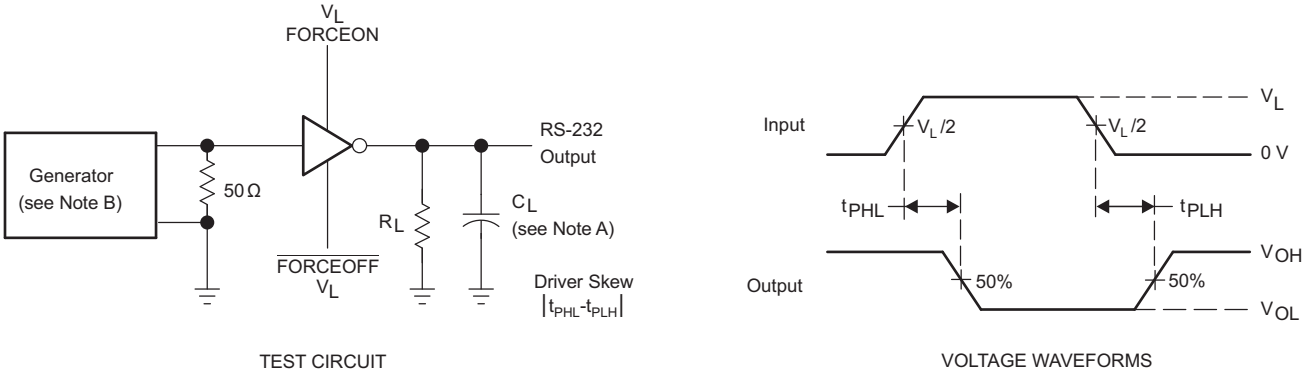
7 Parameter Measurement Information



A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 1000 kbit/s, Z_O = 50 Ω, 50% duty cycle, t_r ≤ 10 ns, t_f ≤ 10 ns.

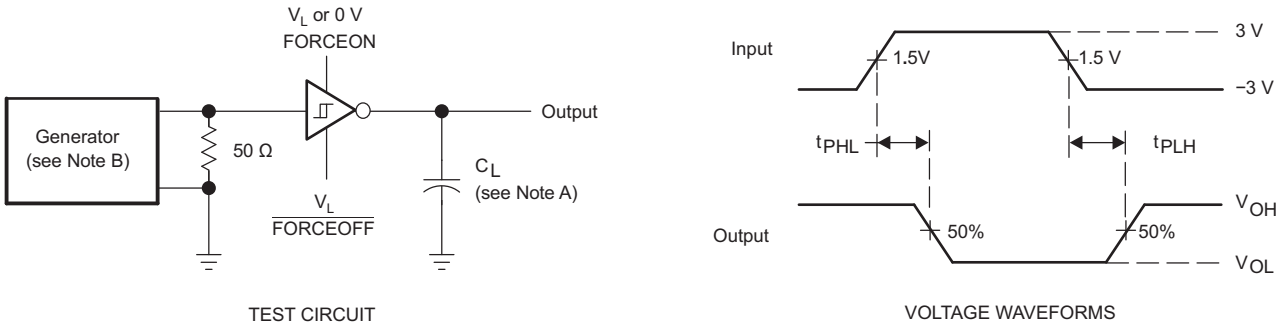
Figure 7. Driver Slew Rate



A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 1000 kbit/s, Z_O = 50 Ω, 50% duty cycle, t_r ≤ 10 ns, t_f ≤ 10 ns.

Figure 8. Driver Pulse Skew

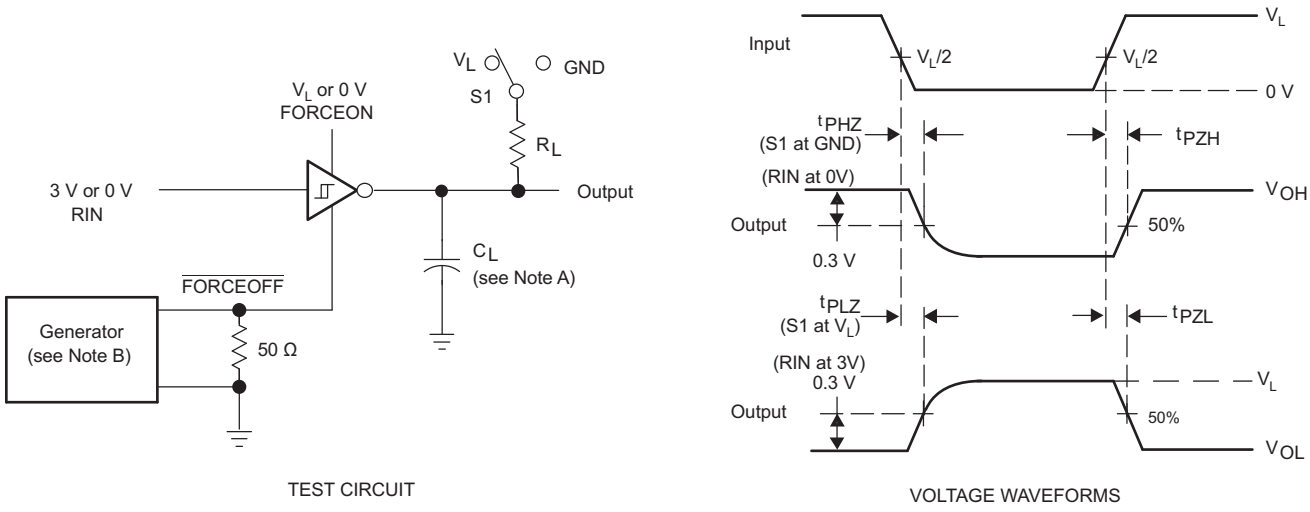


A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: Z_O = 50 Ω, 50% duty cycle, t_r ≤ 10 ns, t_f ≤ 10 ns.

Figure 9. Receiver Propagation Delay Times

Parameter Measurement Information (continued)



A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: Z_O = 50 Ω, 50% duty cycle, t_r ≤ 10 ns, t_f ≤ 10 ns.

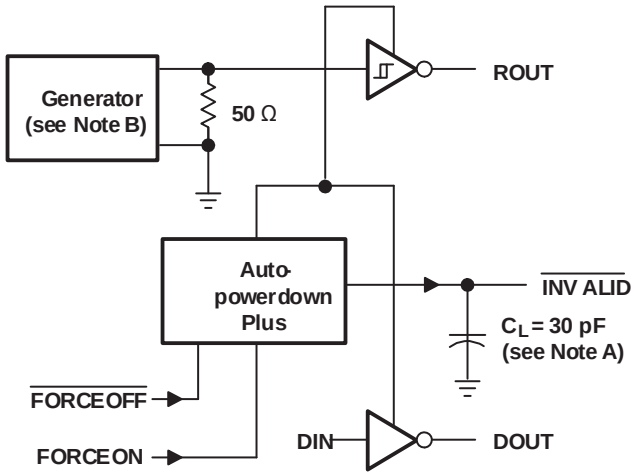
C. t_{PLZ} and t_{PHZ} are the same as t_{dis}.

D. t_{PZL} and t_{PZH} are the same as t_{en}.

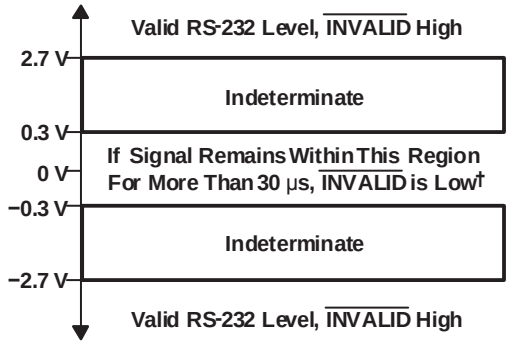
Figure 10. Receiver Enable and Disable Times

Copyright © 2016, Texas Instruments Incorporated

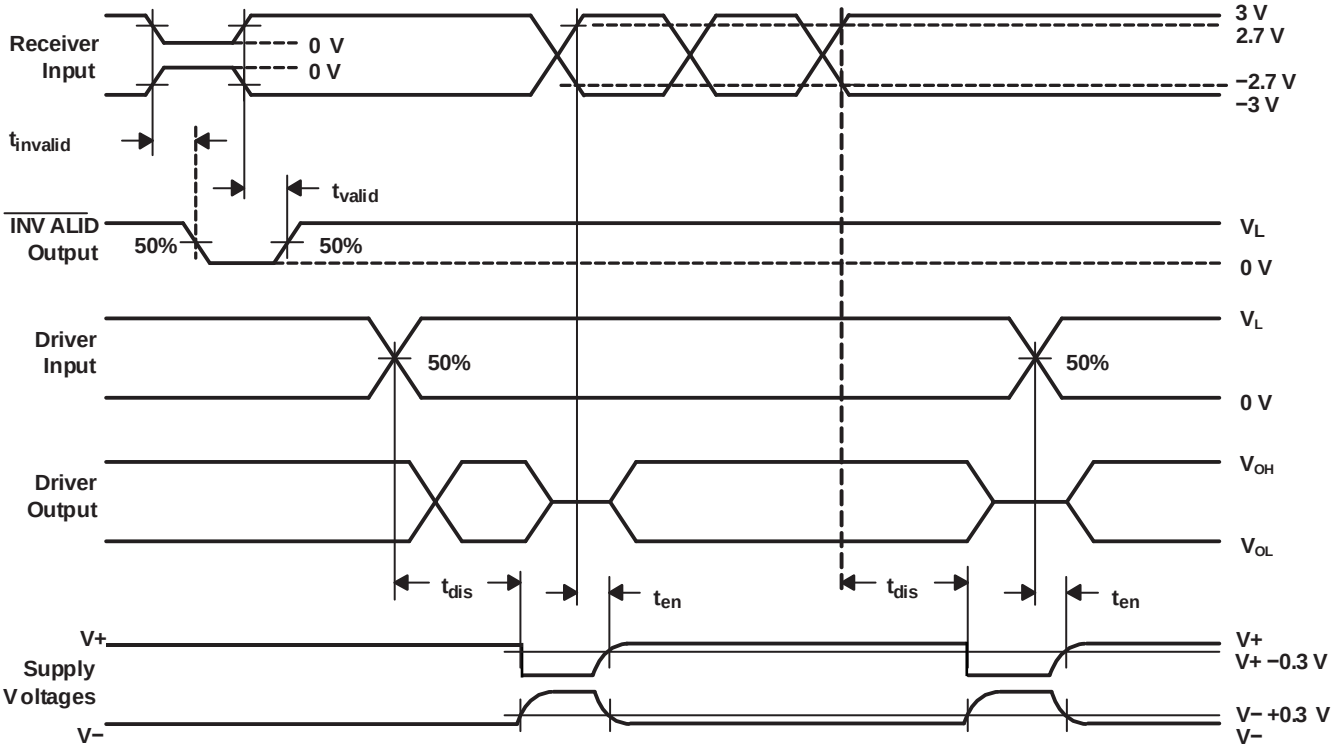
Parameter Measurement Information (continued)



TEST CIRCUIT



† Auto-powerdown plus disables drivers and reduces supply current to 1 µA.



Voltage Waveforms and Timing Diagrams

Figure 11. INVALID Propagation-Delay Times and Supply-Enabling Time

8 Detailed Description

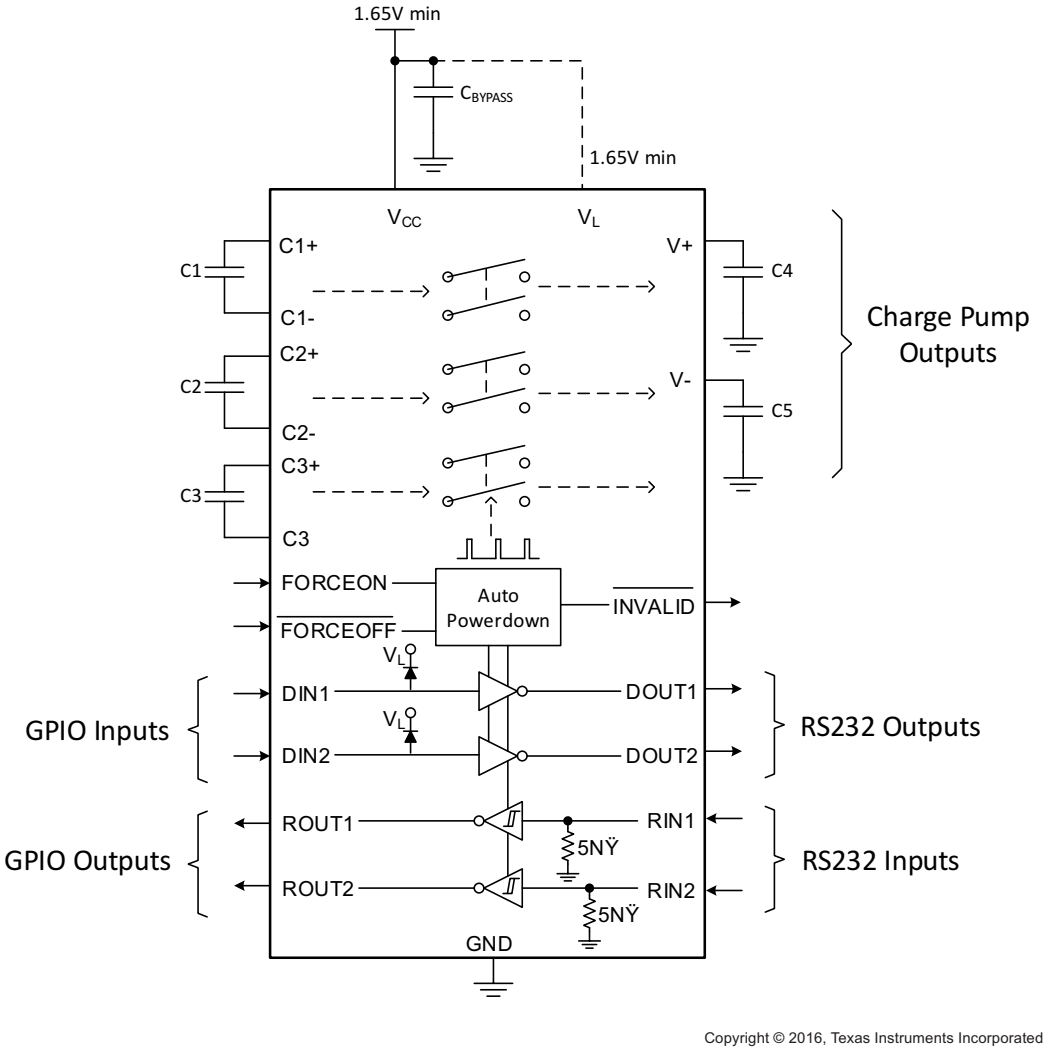
8.1 Overview

The TRS3122E is an upgrade to standard RS232 transceivers, offering compatibility with modern system needs like 1.8-V GPIO capability, enhanced ESD & ultra low stand-by current. The majority of RS-232 transceivers with 1.8-V GPIO compatibility require a logic supply pin for the I/O translation, in addition to a minimum 3.3 V V_{CC} for all of the other active circuitry on the chip. Unlike these transceivers, TRS3122E can operate with both V_L and V_{CC} equal to 1.8 V. When V_{CC}= 3.0 V to 5.5 V, the charge pump will sense V_{CC} and switch to doubler mode. C1 & C2 are the necessary flying capacitors, C3 is not needed, and the charge pump outputs V+ & V- will regulate to ~+/-5.4 V. When V_{CC}= 1.65 V to 2.0 V, the charge pump will sense V_{CC} and switch to tripler mode. C1, C2 & C3 are all necessary, and the charge pump outputs V+ & V- will regulate to ~+/-2.65*V_{CC} from V_{CC}= 1.65 V to 2.0 V.

With many modern applications expanding into products that use RS232 as a backup communication protocol, it is important for the transceiver to have efficient standby operation. In order to accommodate this, Auto Powerdown Plus has been integrated to shut-off all active circuitry, allowing TRS3122E to achieve an I_{off} of 1 uA.

In order to comply with common interface system needs and environments, the RS-232 receive and transmit I/O pins comply with IEC 61000-4-2 ratings.

8.2 Functional Block Diagram



Copyright © 2016, Texas Instruments Incorporated

Figure 12. Schematic

Copyright © 2016, Texas Instruments Incorporated

8.3 Feature Description

8.3.1 Charge Pump

The internal power supply consists of a regulated auto-sensing charge pump that provides RS-232 compatible output voltages, over the 1.65 V to 2.0 V and 3.0 V to 5.5 V V_{CC} ranges. The charge pump operates in two modes to efficiently accommodate low voltage (1.8 V) and higher voltage (3.3 V & 5.0 V) supplies.

8.3.1.1 Doubler Mode

The charge pump requires two flying capacitors (C1, C2) and reservoir capacitors (C4, C5) to generate the V+ and V- supplies of approximately ±5.4 V when V_{CC} is greater than 3 V. When V_{CC} is >2.9V, TRS3122E will sense the supply voltage level and switch the charge pump to a doubler. Hence, no need for a third flying capacitor. C3+ & C3- pins can be left open for proper operation. If a capacitor is placed between C3+ & C3-, the charge pump will ignore this capacitor and still behave as a doubler.

For capacitor choice recommendations, please refer to Table 1.

8.3.1.2 Tripler Mode

The charge pump requires three flying capacitors (C1, C2 & C3) and reservoir capacitors (C4, C5) to generate the V+ and V- supplies of approximately ±2.65 * V_{CC} when V_{CC} is greater than 1.65 V. When V_{CC} is <2.1 V, TRS3122E will sense the supply voltage level and switch the charge pump to a tripler.

For capacitor choice recommendations, please refer to Table 1.

8.3.2 Drivers

The drivers are inverting level transmitters that convert TTL or CMOS logic levels to RS-232 levels. For V_{CC}=3.0 V to 5.0 V, the RS-232 output voltage swing is typically ±5.4 V fully loaded and ±5 V minimum fully loaded. For Vcc = 1.8 V, the RS-232 output voltage swing is typically ±.4.7 V fully loaded and ±4.25 V minimum fully loaded.

The driver outputs are protected against indefinite short-circuits to ground without degradation in reliability. These drivers are compatible with RS-232 logic levels and all previous RS-232 versions. Unused driver inputs should be connected to GND or VCC.

8.3.3 Receivers

The receivers convert EIA/TIA-232 levels to TTL or CMOS logic output levels. Receivers have an inverting output that can be disabled by using the $\overline{\text{FORCEOFF}}$ pin. Receivers remain active when the Auto Powerdown Plus circuitry autonomously enters a low power state. See Auto Powerdown Plus for more information on the Auto Powerdown mode. If the $\overline{\text{FORCEOFF}}$ pin is manually set low, the receivers will be disabled and put into 3-state mode. In either of these powerdown modes, the device will typically consume about 0.5 uA. The truth table logic of the TRS3122E driver and receiver outputs can be found in Device Functional Modes. Since receiver input is usually from a transmission line where long cable lengths and system interference can degrade the signal, the inputs have a typical hysteresis margin of 300 mV. This ensures that the receiver is virtually immune to noisy transmission lines. Should an input be left unconnected, an internal 5kΩ pull-down resistor to ground will commit the output of the receiver to a HIGH state.

8.3.4 ESD Protection

ESD protection structures are incorporated on all pins to protect against electrostatic discharges encountered during handling and assembly. The bus pins (driver outputs and receiver inputs) have extra protection structures, which have been tested up to ±15 kV.

ESD protection is tested in various ways. TI uses the following standards to qualify the ESD structures designed into TRS3122E:

- ±8 kV using IEC 61000-4-2 Contact Discharge (on RINx and DOUTx pins)
- ±15 kV using IEC 61000-4-2 Airgap Discharge (on RINx and DOUTx pins)
- ±15 kV using the Human Body Model (HBM) (on RINx and DOUTx pins)
- ±2 kV using the Human Body Model (HBM) (on all pins except RINx and DOUTx pins)
- ±0.5 kV using the Charged Device Model (CDM) (on all pins)

Copyright © 2016, Texas Instruments Incorporated

Feature Description (continued)

The IEC 61000-4-2 standard is more rigorous than HBM, resulting in lower voltage levels compared with HBM for the same level of ESD protection. Because IEC 61000-4-2 specifies a lower series resistance, the peak current is higher than HBM. The TRS3122E has passed both HBM and IEC 61000-4-2 testing.

8.3.5 Auto Powerdown Plus

Powerdown is engaged in two separate cases: automatically, when no activity has occurred for a period of time, and manually, using the $\overline{\text{FORCEOFF}}$ device pin.

8.3.5.1 Automatic Powerdown

Auto Powerdown Plus is enabled when FORCEON is set LOW and $\overline{\text{FORCEOFF}}$ is set HIGH. Using TRS3122E's integrated edge detection circuitry and timer, the device can sense when there is no activity on the driver or receiver inputs for 30 seconds. When this condition is sensed by the device, it automatically shuts the charge pump off, reducing supply current to 0.5 uA. When a valid transition is sensed on one of the driver or receiver inputs, the charge pump turns back on and TRS3122E exits powerdown. The typical time to exit powerdown is typically in 30 us, but can be as long as 150 us. As a result, the system saves power without requiring any software control. Device Functional Modes summarizes the operating modes in truth table form.

While in the low power mode with Automatic Powerdown enabled ($\overline{\text{FORCEOFF}}$ = HIGH and FORCEON = LOW), the receiver inputs are still enabled.

8.3.5.2 Manual Powerdown

The device can be manually powered down by externally setting $\overline{\text{FORCEOFF}}$ pin to low logic level. Both the drivers and receivers will be powered off. Device Functional Modes summarizes the operating modes in truth table form.

8.3.5.3 Forced On

If the $\overline{\text{FORCEOFF}}$ and FORCEON pins are both set HIGH, the device will power on with Auto Powerdown Plus disabled. Both the drivers and receiver will be active regardless of inactivity. Because powerdown is autonomous, FORCEON can be used ensure drivers are ready for new data transmission if the time since last transmission (or receive data) was more than 15 seconds. Device Functional Modes summarizes the operating modes in truth table form.

Copyright © 2016, Texas Instruments Incorporated

8.4 Device Functional Modes

8.4.1 Each Driver(1)

INPUTS				OUTPUT	DRIVER STATUS
DIN	FORCEON	$\overline{\text{FORCEOFF}}$	TIME ELAPSED SINCE LAST RIN OR DIN TRANSITION	DOUT	
X	X	L	X	Z	Powered off
L	H	H	X	H	Normal operation with auto-powerdown plus disabled
H	H	H	X	L	
L	L	H	<30 s	H	Normal operation with auto-powerdown plus enabled
H	L	H	<30 s	L	
L	L	H	>30 s	Z	Powered off by auto-powerdown plus feature
H	L	H	>30 s	Z	

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off), 30s is typical inactivity time

8.4.2 Each Receiver(1)

INPUTS			OUTPUTS	RECEIVER STATUS
RIN	$\overline{\text{FORCEOFF}}$	TIME ELAPSED SINCE LAST RIN OR DIN TRANSITION	ROUT	
X	L	X	Z	Powered off
L	H	X	H	Normal operation with auto-powerdown plus disabled/enabled
H	H	X	L	
Open	H	X	H	

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off), Open = input disconnected or connected driver off

8.4.3 $\overline{\text{INVALID}}$ Status Truth Table(1)

INPUTS				OUTPUT
RIN1, RIN2	FORCEON	$\overline{\text{FORCEOFF}}$	TIME ELAPSED SINCE LAST RIN OR DIN TRANSITION	$\overline{\text{INVALID}}$
Any L or H	X	X	X	H
All Open	X	X	X	L

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off), Open = input disconnected or connected driver off

8.4.4 Capacitor Selection Table

Table 1. Capacitor Selection

V_{CC} = V_L	C1 Capacitor Value	C2 Capacitor Value	C3 Capacitor Value	C4 Capacitor Value	C5 Capacitor Value
1.65 V to 2 V(1)	100 nF				
3.0 V to 3.6 V(1)	100 nF		100 nF or open	100 nF	
4.5 V to 5.5 V(1)	47 nF	330 nF	100 nF or open	330 nF	
3 V to 5.5 V(2)	47 nF	470 nF	100 nF or open	470 nF	

(1) For optimized performance, we recommend using these configurations.
(2) For applications where the Vcc variation is larger, this configuration is acceptable.

Copyright © 2016, Texas Instruments Incorporated

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

RS232 is used to communicate between two electrical units on separate PCBs across cables <40 ft. Common RS232 cables are RJ45, DB9 & DB25.

9.2 Typical 1.8-V Application

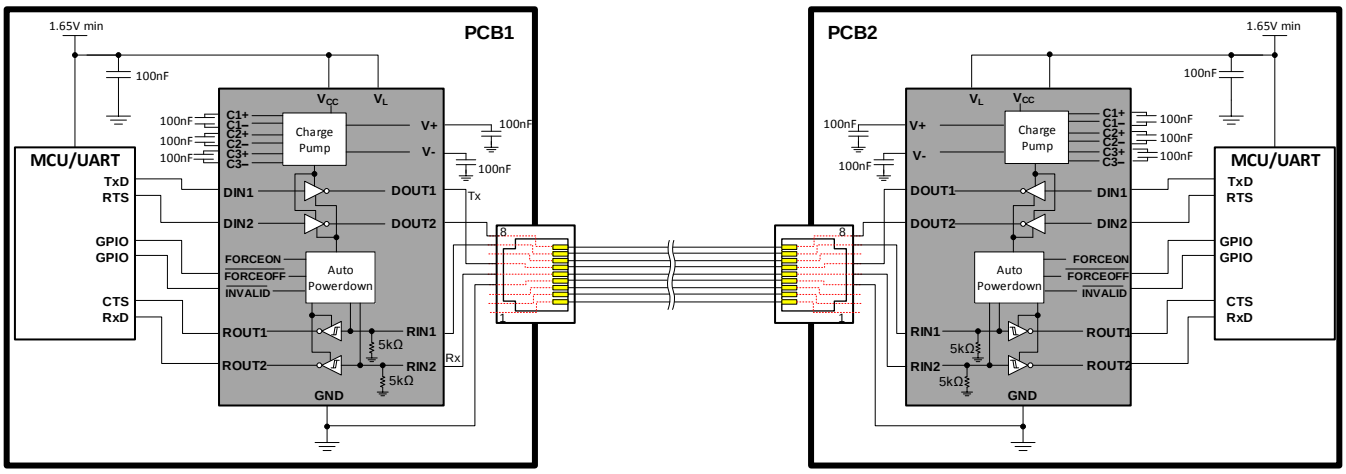


Figure 13. TRS3122E Typical Application

9.2.1 Design Requirements

For this design example, use the parameters listed in Table 2 as the input parameters.

Table 2. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
MCU GPIO Supple Voltage	1.8 V
Transmission Voltage	+/-4.7 V
Data-rate	1 Mbps
Number of Transmitters / Receivers	2
Charge Pump Capacitor Values	100nF (see Table 3)

9.2.2 Detailed Design Procedure

When using TRS3122E, determine the following:

- All DIN, $\overline{\text{FORCEOFF}}$, and FORCEON inputs must be connected to valid low or high logic levels.
- Select capacitor values based on V_{CC} level for best performance. (see Table 3)

Copyright © 2016, Texas Instruments Incorporated

9.2.2.1 Data-Rate and Cable Length

RS-232 intended is for short range data transmission. The rise time for RS-232 driver edges is slow enough that the data cable appears as a capacitor instead of a transmission line impedance. The elapsed time for one bit of data far exceeds the transit time of any practical RS-232 cable length. The capacitance of the cable is the limiting factor. Therefore the capacitance per foot (or meter) of the cable is important if long data cables are used. Capacitance slows the rise and fall time of the signal. For low data rates, the delay is insignificant. However, high data rates will have reduced percentage of time that the output is at V_{OL} or V_{OH} and more time in the transitions. The timing of the UART (universal asynchronous receiver/transmitter) must sample the signal at the right time to coincide with V_{OL} and V_{OH} plateaus. At some point data reliability will be impacted. There are no hard limits for cable capacitance and data rate.

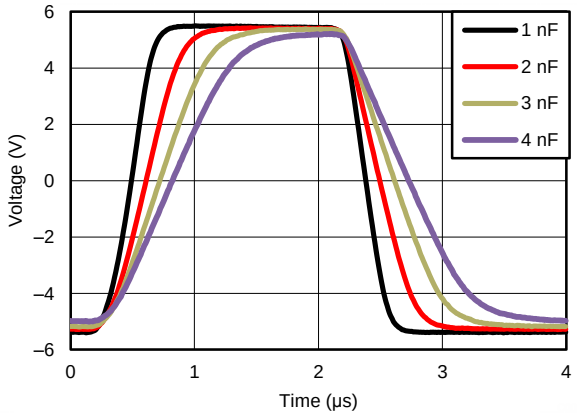


Figure 14. Typical Waveform with Capacitive Load
V_{CC} = 3.3 V, R_{LOAD} = 3 kΩ, Date Rate = 500kbps

The maximum cable length depends on the cable used (pf/ft), data rate, timing of receiving UART, system tolerance to data errors.

9.2.2.2 Capacitor Selection

The capacitor type used for C1–C5 is not critical for proper operation; polarized or non-polarized capacitors can be used, though lower ESR capacitors are preferred. The charge pump requires 0.1 µF capacitors for V_{CC} = 1.8-V or V_{CC} = 3.3-V operation. For other supply voltages, see Table 1 for required capacitor values. Do not use values smaller than those listed in Table 1. Increasing the capacitor values(e.g., by a factor of 2), except for C1, reduces ripple on the transmitter outputs and slightly reduces power consumption. C2, C3, C4 and C5 can be increased without changing C1's value. However, do not increase C1 without also increasing the values of C2, C3, C4, C5, $C_{BYPASS1}$, and $C_{BYPASS2}$ to maintain the proper ratios (C1 to the other capacitors). When using the minimum required capacitor values, make sure the capacitor value does not degrade excessively with temperature. If in doubt, use capacitors with a larger nominal value. The capacitor's equivalent series resistance (ESR) usually increases at low temperatures.

For best charge pump efficiency locate the charge pump and bypass capacitors as close as possible to the IC. Surface mount capacitors are best for this purpose. Using capacitors with lower equivalent series resistance (ESR) and self-inductance, along with minimizing parasitic PCB trace inductance will optimize charge pump operation. Designers are also advised to consider that capacitor values may shift over time and operating temperature.

Table 3. Capacitor Selection

V_{CC} = V_L	C1 Capacitor Value	C2 Capacitor Value	C3 Capacitor Value	C4 Capacitor Value	C5 Capacitor Value
1.65 V to 2 V(1)	100 nF				
3.0 V to 3.6 V(1)	100 nF		100 nF or open	100 nF	
4.5 V to 5.5 V(1)	47 nF	330 nF	100 nF or open	330 nF	
3 V to 5.5 V(2)	47 nF	470 nF	100 nF or open	470 nF	

(1) For optimized performance, we recommend using these configurations.
(2) For applications where the Vcc variation is larger, this configuration is acceptable.

Copyright © 2016, Texas Instruments Incorporated

9.2.3 Application Curves

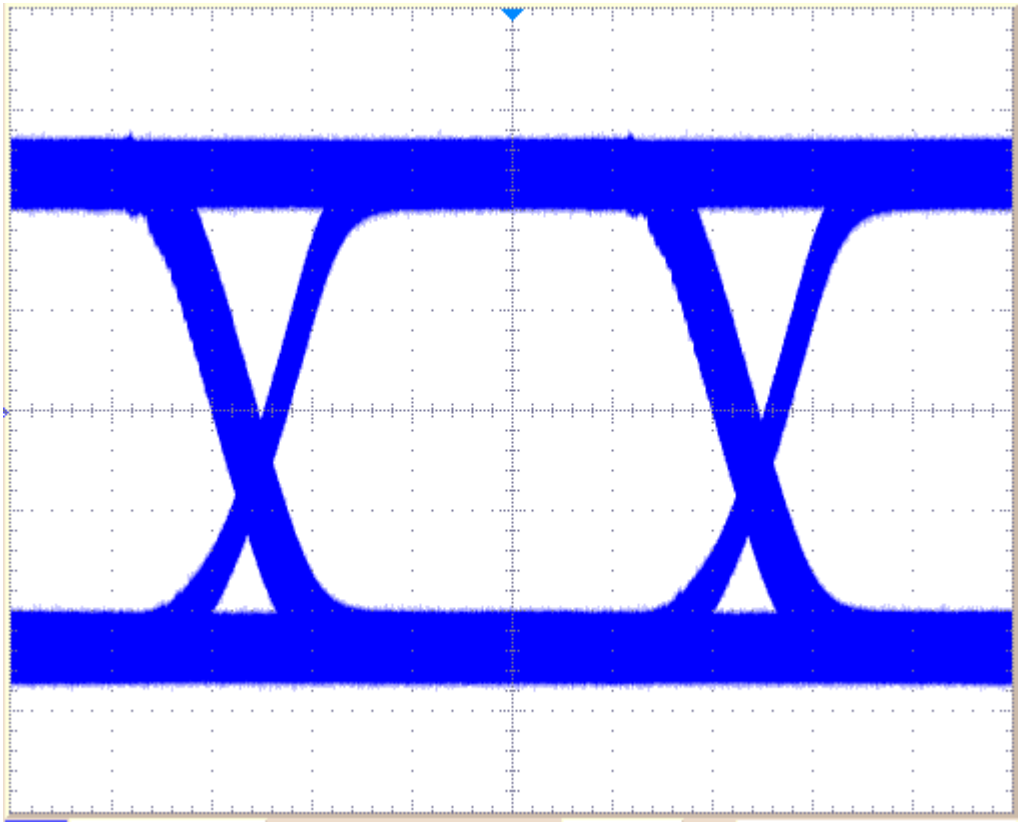


Figure 15. 1 Mbps Eye Diagram, 2 V/div, 200 ns/ div
V_{CC} = 1.8 V, C_{LOAD} = 500 pF, R_{LOAD} = 3 kΩ

10 Power Supply Recommendations

In most circumstances, a 0.1-μF V_{CC} bypass capacitor and a 1-μF V_L bypass capacitor are adequate. In applications that are sensitive to power-supply noise, use larger value V_{CC} bypass capacitor. There is no maximum limit for bypass capacitor. Place bypass capacitors as close to the IC as possible.

It is not recommended to use this device when V_{CC} is powered and V_L= 0 V or floating for an extended period of time because operation is undefined. V_{CC} and V_L must be powered to guarantee charge pump operation.

Also, to achieve full functionality as described in Specifications, it is recommended to not use a higher voltage on V_L than V_{CC}. Full functionality can be achieved when V_{CC} is greater than or equal to V_L.

Copyright © 2016, Texas Instruments Incorporated

11 Layout

11.1 Layout Guidelines

Minimize the length of all capacitor traces to ensure the device can maintain quick rising and falling transitions. Vias are recommended to accommodate layouts for the capacitors.

11.2 Layout Example

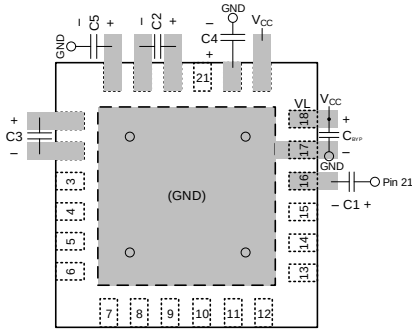


Figure 16. TRS3122E Typical Layout

12 Device and Documentation Support

12.1 Device Support

12.1.1 Third-Party Products Disclaimer

TI'S PUBLICATION OF INFORMATION REGARDING THIRD-PARTY PRODUCTS OR SERVICES DOES NOT CONSTITUTE AN ENDORSEMENT REGARDING THE SUITABILITY OF SUCH PRODUCTS OR SERVICES OR A WARRANTY, REPRESENTATION OR ENDORSEMENT OF SUCH PRODUCTS OR SERVICES, EITHER ALONE OR IN COMBINATION WITH ANY TI PRODUCT OR SERVICE.

12.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community ***TI's Engineer-to-Engineer (E2E) Community.*** Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support ***TI's Design Support*** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.3 Trademarks

E2E is a trademark of Texas Instruments.

12.4 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.5 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Copyright © 2016, Texas Instruments Incorporated

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TRS3122ERGER	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3122
TRS3122ERGER.A	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3122
TRS3122ERGERG4	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3122
TRS3122ERGERG4.A	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3122
TRS3122ERGET	Active	Production	VQFN (RGE) | 24	250 | SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3122
TRS3122ERGET.A	Active	Production	VQFN (RGE) | 24	250 | SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3122

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

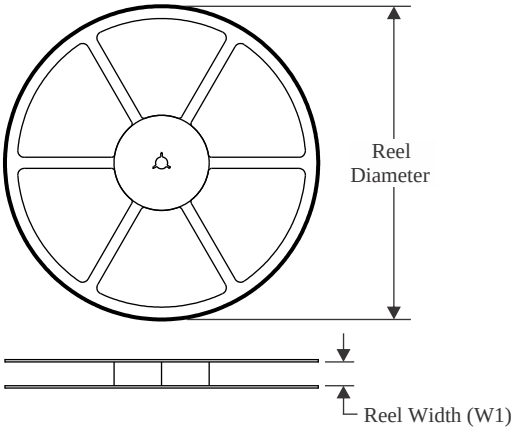
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

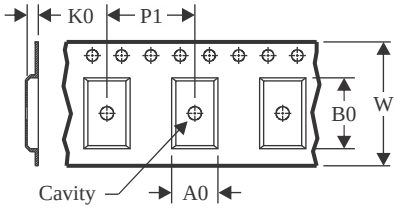
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

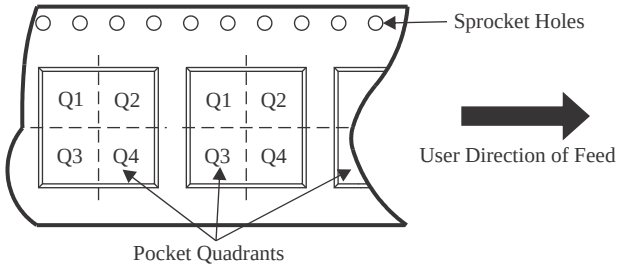


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

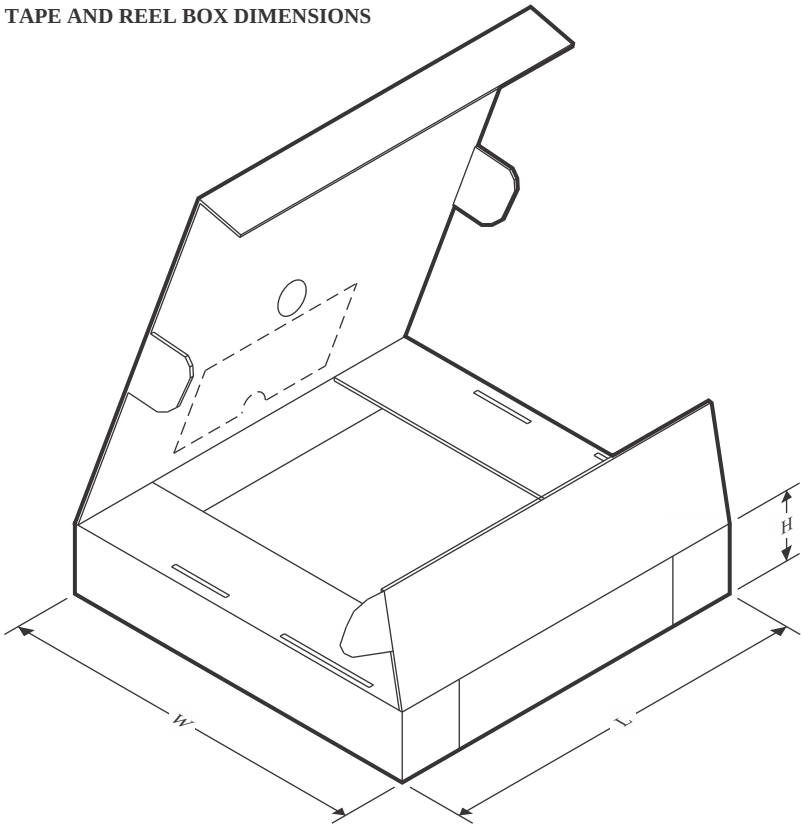
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRS3122ERGER	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TRS3122ERGERG4	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TRS3122ERGET	VQFN	RGE	24	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS



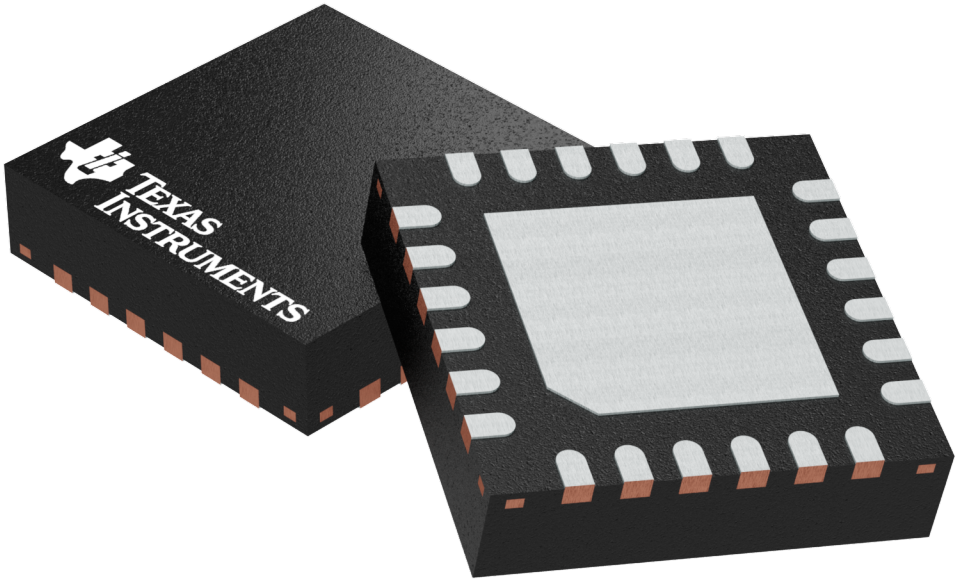
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TRS3122ERGER	VQFN	RGE	24	3000	360.0	360.0	36.0
TRS3122ERGERG4	VQFN	RGE	24	3000	367.0	367.0	35.0
TRS3122ERGET	VQFN	RGE	24	250	210.0	185.0	35.0

RGE 24

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



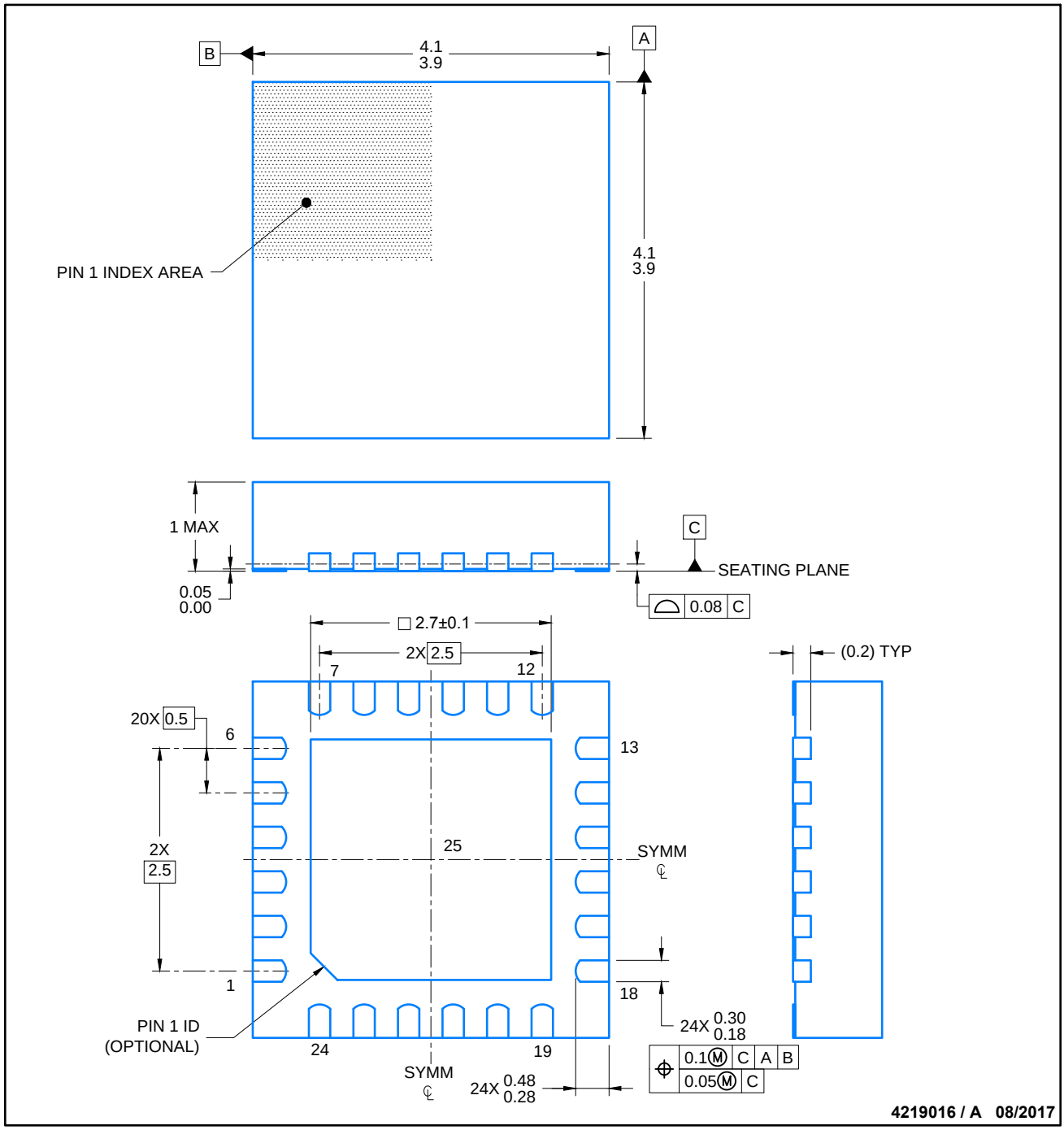
Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

PACKAGE OUTLINE

RGE0024H

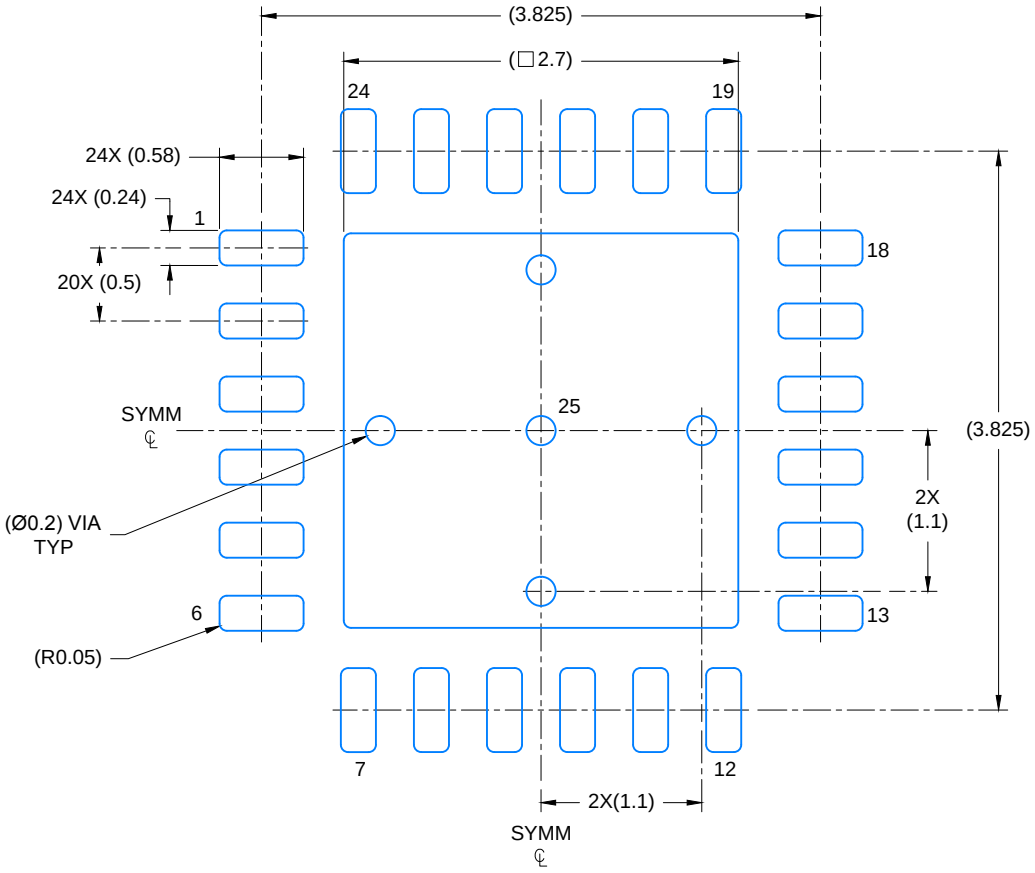
VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



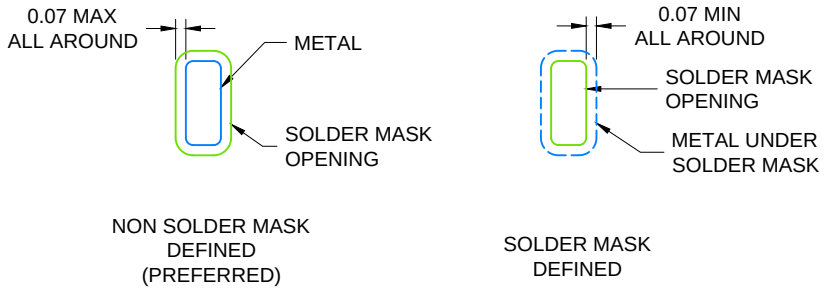
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



LAND PATTERN EXAMPLE

SCALE: 20X

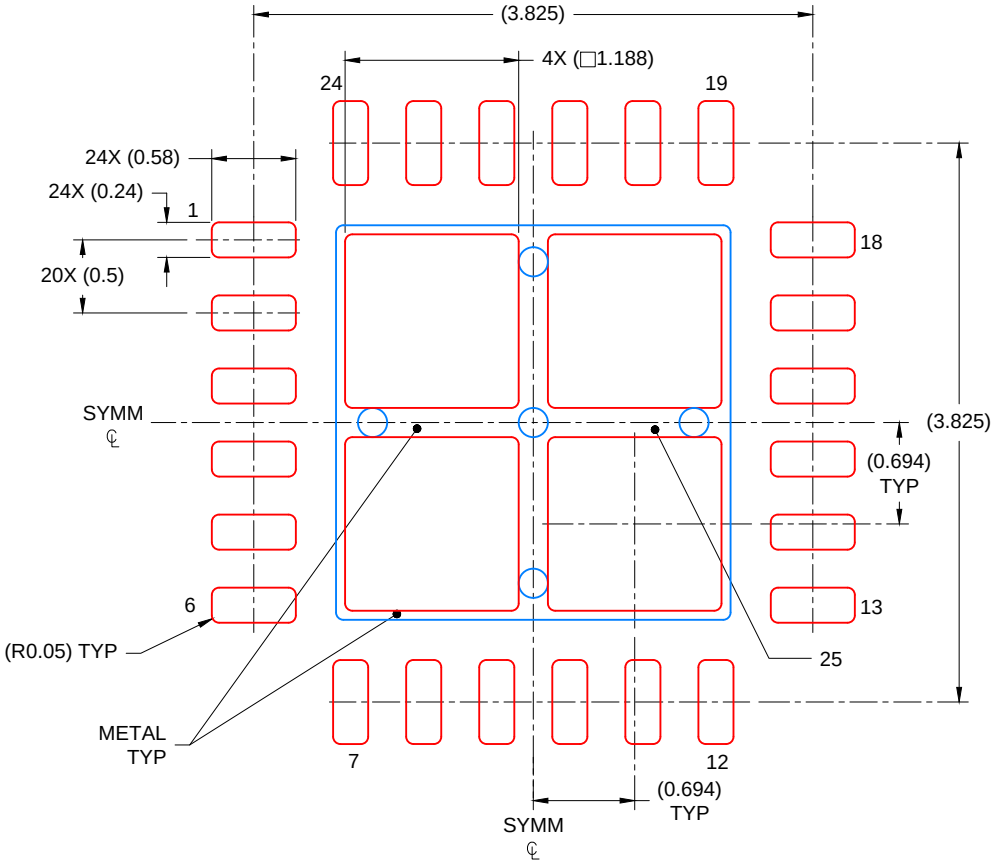


SOLDER MASK DETAILS

4219016 / A 08/2017

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
78% PRINTED COVERAGE BY AREA
SCALE: 20X

4219016 / A 08/2017

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES “AS IS” AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI’s products are provided subject to TI’s Terms of Sale, TI’s General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI’s provision of these resources does not expand or otherwise alter TI’s applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2026, Texas Instruments Incorporated

Last updated 10/2025